Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
Service suisse d'étalonnage
Servizio svizzero di taratura
S Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client

UL

Fremont, USA

Certificate No.

EX-7810\_May25

### **CALIBRATION CERTIFICATE**

Object

EX3DV4 - SN:7810

Calibration procedure(s)

QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6,

QA CAL-25.v8

Calibration procedure for dosimetric E-field probes

Calibration date

May 08, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22\pm3)^{\circ}$ C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards ID		Calibration Date (Certificate No.)	Sched. Cal.
Power Sensor R&S NRP-33T	SN: 100967	26-Mar-25 (No. 217-04290)	Mar-26
Type-N mismatch combination	SN: L1119	26-Mar-25 (No. 217-04292)	Mar-26
OCP DAK-12	SN: 1016	24-Sept-24 (No. OCP-DAK12-1016_Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sept-24 (No. OCP-DAK3.5-1249_Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4	SN: 1301	07-Nov-24 (No. DAE4-1301_Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched. Check
	SN: L1404	30-Sept-24 (No. Report_ACAP2020E-Cave_20240930s)	Sep-25

Name

Function

Signature

Calibrated by

Aidonia Georgiadou

Laboratory Technician

Approved by

Sven Kühn

Technical Manager

Issued: May 08, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: EX-7810\_May25

Page 1 of 22

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#### Glossary

TSL NORMx,y,z

tissue simulating liquid sensitivity in free space

ConvF

sensitivity in TSL / NORMx,y,z

DCP

diode compression point

CF A, B, C, D crest factor (1/duty\_cycle) of the RF signal modulation dependent linearization parameters

Polarization  $\varphi$ 

 $\varphi$  rotation around probe axis

Polarization  $\vartheta$ 

 $\vartheta$  rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e.,  $\vartheta = 0$  is

normal to probe axis

Connector Angle

information used in DASY system to align probe sensor X to the robot coordinate system

## Calibration is Performed According to the Following Standards:

- a) IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices - Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- b) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

### Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization  $\vartheta = 0$  ( $f \le 900 \, \text{MHz}$  in TEM-cell;  $f > 1800 \, \text{MHz}$ : R22 waveguide). NORMx, y, z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not affect the E2-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z \* frequency\_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \le 800 \,\mathrm{MHz}$ ) and inside waveguide using analytical field distributions based on power measurements for  $f > 800 \,\mathrm{MHz}$ . The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx, y, z \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from  $+50 \,\mathrm{MHz}$  to  $\pm 100 \,\mathrm{MHz}$ .
- · Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Page 2 of 22 Certificate No: EX-7810\_May25

EX3DV4 - SN:7810 May 08, 2025

# Parameters of Probe: EX3DV4 - SN:7810

#### **Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc $(k=2)$
Norm $(\mu V/(V/m)^2)^A$	0.59	0.69	0.65	±10.1%
DCP (mV) B	110.1	107.0	106.4	±4.7%

## **Calibration Results for Modulation Response**

UID	Communication System Name		A dB	B dBõV	С	dB	VR mV	Max dev.	Max Unc <sup>E</sup> k = 2
0	CW	X	0.00	0.00	1.00	0.00	143.7	±1.2%	±4.7%
		Y	0.00	0.00	1.00		130.4		
		Z	0.00	0.00	1.00		149.4		
10352	Pulse Waveform (200Hz, 10%)	X	1.63	60.95	6.48	10.00	60.0	±2.6%	±9.6%
	·	Y	1.40	60.00	5.96		60.0		
		Z	1.47	60.43	6.35		60.0		
10353	Pulse Waveform (200Hz, 20%)	X	0.84	60.00	4.91	6.99	80.0	±2.4%	±9.6%
	, , , , , , , , , , , , , , , , , , ,	Y	0.81	60.00	4.80		80.0		
		Z	46.00	80.00	11.00		80.0		
10354	Pulse Waveform (200Hz, 40%)	X	0.45	60.00	3.73	3.98	95.0	±2.7%	±9.6%
	, , , ,	Y	0.01	125.28	0.33		95.0	İ	
		Z	0.16	140.59	0.19		95.0		
10355	Pulse Waveform (200Hz, 60%)	X	10.11	89.44	0.01	2.22	120.0	±1.7%	±9.6%
	, , ,	Y	5.95	159.98	1.45		120.0	1	
		Z	6.49	160.00	15.35		120.0		
10387	QPSK Waveform, 1 MHz	X	0.49	64.70	13.41	1.00	150.0	±3.1%	±9.6%
	· ·	Y	0.45	62.15	11.58		150.0	1	
		Z	0.58	65.39	13.98		150.0		
10388	QPSK Waveform, 10 MHz	X	1.31	67.40	14.22	0.00	150.0	±1.0%	±9.6%
		Y	1.21	65.18	13.33		150.0	1	
		Z	1.42	67.34	14.78		150.0		
10396	64-QAM Waveform, 100 kHz	X	1.77	65.53	16.12	3.01	150.0	±1.1%	±9.6%
		Y	1.60	63.78	15.63		150.0		
		Z	1.65	64.26	16.05		150.0		
10399	64-QAM Waveform, 40 MHz	X	2.77	67.03	15.36	0.00	150.0	±1.5%	±9.6%
		Y	2.71	65.99	14.88		150.0	]	
		Z	2.84	66.65	15.41		150.0		
10414	WLAN CCDF, 64-QAM, 40 MHz	X	3.63	66.58	15.33	0.00	150.0	±2.5%	±9.6%
	, , ,	Y	3.80	66.44	15.38		150.0	1	
		Z	3.92	66.81	15.73		150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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A The uncertainties of Norm X,Y,Z do not affect the E<sup>2</sup>-field uncertainty inside TSL (see Pages 5 and 6).

B Linearization parameter uncertainty for maximum specified field strength.

E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

May 08, 2025

# Parameters of Probe: EX3DV4 - SN:7810

## **Sensor Model Parameters**

	C1	C2	α	T1	T2	Т3	T4	T5	T6
	fF	fF	V <sup>−1</sup>	ms V <sup>-2</sup>	ms V <sup>-1</sup>	ms	V <sup>-2</sup>	V <sup>-1</sup>	
х	7.3	50.94	31.44	3.84	0.00	4.90	0.64	0.00	1.00
v	8.6	62.10	33.06	2.90	0.00	4.90	0.28	0.00	1.00
z	8.9	64.32	33.53	2.32	0.00	4.90	0.30	0.00	1.00

## **Other Probe Parameters**

Sensor Arrangement	Triangular
Connector Angle	63.5°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3-4 mm for an Area Scan job.

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EX3DV4 - SN:7810 May 08, 2025

## Parameters of Probe: EX3DV4 - SN:7810

#### Calibration Parameter Determined in HSL

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> (k = 2)
750	41.9	0.89	9.62	9.50	9.76	0.36	1.27	±11.0%
900	41.5	0.97	9.08	8.97	9.21	0.36	1.27	±11.0%
1450	40.5	1.20	7.93	7.83	8.05	0.36	1.27	±11.0%
1640	40.2	1.31	7.74	7.65	7.86	0.36	1.27	±11.0%
1750	40.1	1.37	7.81	7.72	7.93	0.36	1.27	±11.0%
1900	40.0	1.40	7.72	7.63	7.84	0.36	1.27	±11.0%
2100	39.8	1.49	7.51	7.42	7.62	0.36	1.27	±11.0%
2300	39.5	1.67	7.51	7.42	7.62	0.36	1.27	±11.0%
2450	39.2	1.80	7.31	7.22	7.42	0.36	1.27	±11.0%
2600	39.0	1.96	7.16	7.08	7.27	0.36	1.27	±11.0%
3300	38.2	2.71	6.31	6.23	6.40	0.37	1.27	±13.1%
3500	37.9	2.91	6.38	6.30	6.47	0.37	1.27	±13.1%
3700	37.7	3.12	6.37	6.29	6.46	0.37	1.27	±13.1%
3900	37.5	3.32	6.21	6.14	6.30	0.37	1.27	±13.1%
4100	37.2	3.53	6.08	6.00	6.17	0.37	1.27	±13.1%
4200	37.1	3.63	6.14	6.07	6.23	0.37	1.27	±13.1%
4400	36.9	3.84	5.95	5.88	6.04	0.37	1.27	±13.1%
4600	36.7	4.04	5.84	5.77	5.93	0.37	1.27	±13.1%
4800	36.4	4.25	6.00	5.93	6.09	0.37	1.27	±13.1%
4950	36.3	4.40	5.88	5.81	5.97	0.35	1.27	±13.1%
5250	35.9	4.71	5.71	5.64	5.79	0.32	1.27	±13.1%
5600	35.5	5.07	5.28	5.22	5.36	0.29	1.27	±13.1%
5750	35.4	5.22	5.23	5.16	5.31	0.27	1.27	±13.1%
5850	35.2	5.32	5.36	5.29	5.44	0.26	1.27	±13.1%

C Frequency validity above 300 MHz of  $\pm 100$  MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to  $\pm 50$  MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is  $\pm 10$ , 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to  $\pm 110$  MHz.

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F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 5\%$  from the target values (typically better than  $\pm 3\%$ ) and are valid for TSL with deviations of up to  $\pm 10\%$  if SAR correction is applied.

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

EX3DV4 - SN:7810 May 08, 2025

# Parameters of Probe: EX3DV4 - SN:7810

#### Calibration Parameter Determined in HSL

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> (k = 2)
6500	34.5	6.07	5.17	5.11	5.25	0.20	1.27	±18.6%

C Frequency validity is -600/+700 MHz at 6.5 GHz, ±700 MHz at or above 7 GHz, and ±150 MHz at 9.85 GHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Certificate No: EX-7810\_May25 Page 6 of 22

F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 10\%$  from the target values (typically better than  $\pm 6\%$ ) and are valid for TSL with deviations of up to  $\pm 10\%$ .

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less

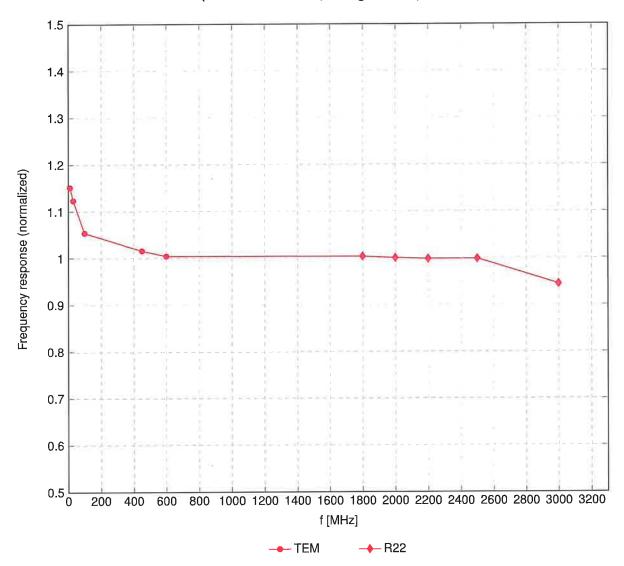
G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz; below ±2% for frequencies between 3–6 GHz; and below ±4% for frequencies between 6–10 GHz at any distance larger than half the probe tip diameter from the boundary.

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

May 08, 2025

# Frequency Response of E-Field

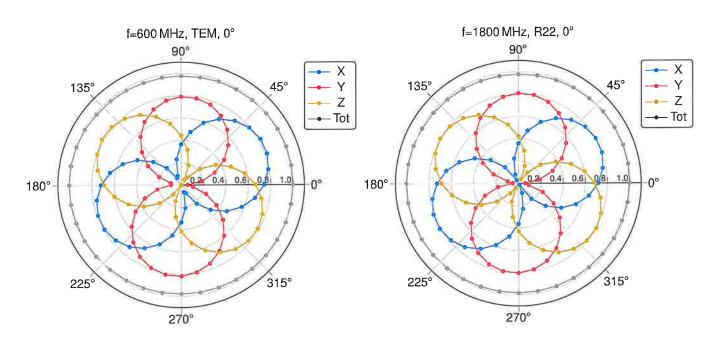
(TEM-Cell:ifi110 EXX, Waveguide:R22)

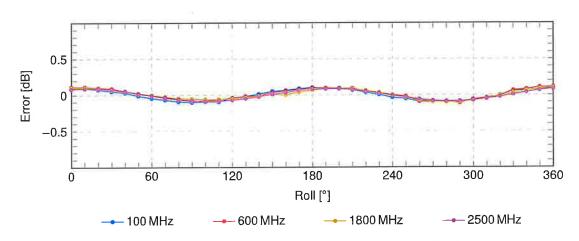


Uncertainty of Frequency Response of E-field: ±6.3% (k=2)

May 08, 2025

# Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$

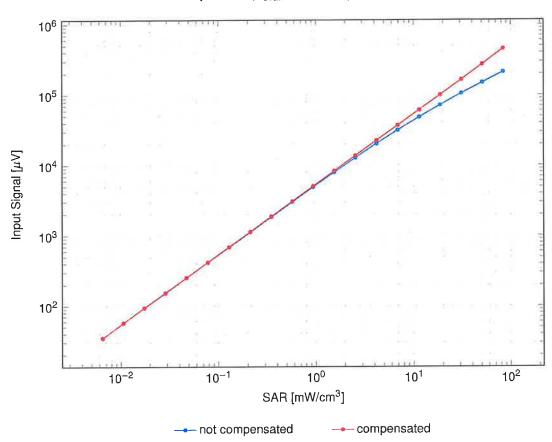


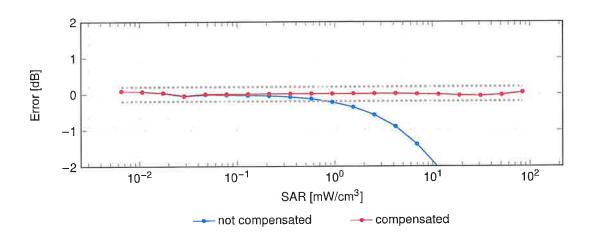


Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  (k=2)

# $\textbf{Dynamic Range } \textbf{f}(\textbf{SAR}_{\textbf{HSL}})$

(TEM cell,  $f_{eval} = 1900\,\text{MHz})$ 

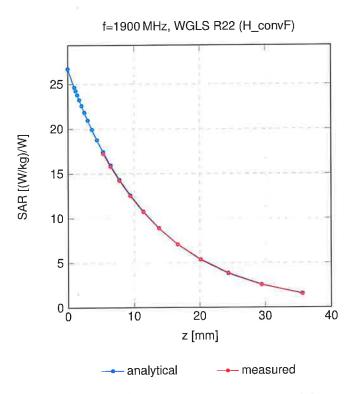




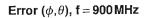
Uncertainty of Linearity Assessment:  $\pm 0.6\%$  (k=2)

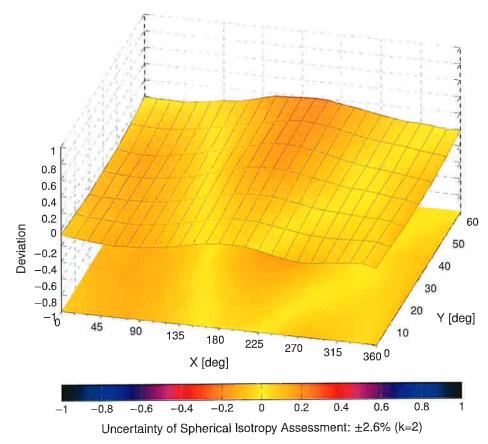
EX3DV4 - SN:7810 May 08, 2025

## **Conversion Factor Assessment**



# **Deviation from Isotropy in Liquid**





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Client

UL

Fremont, USA

Certificate No.

EX-3990 Feb25

### **CALIBRATION CERTIFICATE**

Object

EX3DV4 - SN:3990

Calibration procedure(s)

QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6,

**QA CAL-25.v8** 

Calibration procedure for dosimetric E-field probes

Calibration date

February 07, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22\pm3)$  °C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched. Cal.
Power Sensor R&S NRP-33T	SN: 100967	28-Mar-24 (No. 217-04038)	Mar-25
Short [S6019i] + Attenuator [S6020i]	SN: L1119	26-Mar-24 (No. 217-04048)	Mar-25
OCP DAK-12	SN: 1016	24-Sept-24 (No. OCP-DAK12-1016_Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sept-24 (No. OCP-DAK3.5-1249_Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349 Jan25)	Jan-26
DAE4	SN: 1301	07-Nov-24 (No. DAE4-1301_Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched. Check
ACAP 2020 Calibration Box	SN: L1404	30-Sept-24 (No. Report_ACAP2020E-Cave_20240930s)	Sep-25

Name Function Signature

Calibrated by Paulo Pina Laboratory Technician

Approved by Sven Kühn Technical Manager

Issued: February 07, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: EX-3990\_Feb25

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#### Glossary

TSL tissue simulating liquid

NORMx,y,z sensitivity in free space

ConvF sensitivity in TSL / NORMx,y,z

DCP diode compression point

CF crest factor (1/duty\_cycle) of the RF signal A, B, C, D modulation dependent linearization parameters

Polarization  $\varphi$   $\varphi$  rotation around probe axis

Polarization  $\vartheta$   $\vartheta$  rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e.,  $\vartheta = 0$  is

normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

#### Calibration is Performed According to the Following Standards:

a) IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices – Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.

b) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

#### **Methods Applied and Interpretation of Parameters:**

- *NORMx,y,z*: Assessed for E-field polarization  $\vartheta = 0$  ( $f \le 900\,\text{MHz}$  in TEM-cell;  $f > 1800\,\text{MHz}$ : R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not affect the E<sup>2</sup>-field uncertainty inside TSL (see below *ConvF*).
- NORM(f)x,y,z = NORMx,y,z \* frequency\_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- · PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ±50 MHz to ±100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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EX3DV4 - SN:3990 February 07, 2025

## Parameters of Probe: EX3DV4 - SN:3990

#### **Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc (k = 2)
Norm $(\mu V/(V/m)^2)$ A	0.61	0.62	0.62	±10.1%
DCP (mV) B	100.7	100.5	99.6	±4.7%

### **Calibration Results for Modulation Response**

UID	Communication System Name		A	B dD /w/	С	D dB	VR mV	Max dev.	Max Unc <sup>E</sup>
			dB	dB√μV		uв	IIIV		k = 2
0	CW	X	0.00	0.00	1.00	0.00	145.2	±0.7%	±4.7%
		Y	0.00	0.00	1.00		141.1		
		Z	0.00	0.00	1.00		121.1		
10352	Pulse Waveform (200Hz, 10%)	X	84.00	108.00	25.00	10.00	60.0	±3.2%	±9.6%
		Y	20.00	89.32	19.50		60.0		
		Z	20.00	94.17	22.38		60.0		
10353	Pulse Waveform (200Hz, 20%)	X	20.00	94.32	21.38	6.99	80.0	±1.5%	±9.6%
	,	Y	20.00	90.15	19.01		80.0		
		Z	20.00	98.86	23.69		80.0		
10354	Pulse Waveform (200Hz, 40%)	X	20.00	98.72	22.24	3.98	95.0	±1.1%	±9.6%
	,	Y	20.00	91.78	18.66	1	95.0	[	
		Z	20.00	100.96	23.30	i	95.0		
10355	Pulse Waveform (200Hz, 60%)	X	20.00	103.98	23.46	2.22	120.0	±1.1%	±9.6%
	, , , ,	Y	20.00	95.35	19.28	1	120.0	1	
		Z	20.00	105.45	24.08		120.0		
10387	QPSK Waveform, 1 MHz	X	1.65	65.31	14.46	1.00	150.0	±1.8%	±9.6%
	,	Y	1.69	65.94	14.79		150.0	1	
		Z	1.60	64.85	14.07		150.0	i	
10388	QPSK Waveform, 10 MHz	X	2.17	67.14	15.16	0.00	150.0	±1.2%	±9.6%
	,	Y	2.25	67.84	15.53	Ī	150.0		
		Z	2.11	66.59	14.80	1	150.0	i	
10396	64-QAM Waveform, 100 kHz	X	2.77	69.26	18.11	3.01	150.0	±0.7%	±9.6%
		Y	2.80	69.79	18.43		150.0	1	
		Z	2.66	68.61	17.83	İ	150.0		
10399	64-QAM Waveform, 40 MHz	X	3.34	66.11	15.17	0.00	150.0	±1.0%	±9.6%
		Y	3.40	66.50	15.39	1	150.0	1	
		Z	3.30	65.81	14.97	1	150.0		
10414	WLAN CCDF, 64-QAM, 40 MHz	X	4.74	65.05	15.14	0.00	150.0	±2.2%	±9.6%
		Y	4.78	65.27	15.27	1	150.0	1	
		Z	4.71	64.91	15.04	Ī	150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

B Linearization parameter uncertainty for maximum specified field strength.

 $<sup>^{\</sup>rm A}$  The uncertainties of Norm X,Y,Z do not affect the  ${\rm E^2}$ -field uncertainty inside TSL (see Pages 5 and 6).

E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

February 07, 2025

# Parameters of Probe: EX3DV4 - SN:3990

### **Sensor Model Parameters**

	C1 fF	C2 fF	α V <sup>-1</sup>	T1 msV <sup>-2</sup>	T2 msV <sup>-1</sup>	T3 ms	T4 V <sup>-2</sup>	T5 V <sup>-1</sup>	Т6
х	46.4	342.58	34.81	15.50	0.01	5.09	0.95	0.25	1.01
у	45.6	337.22	34.81	18.01	0.00	5.05	0.91	0.24	1.01
Z	44.9	333.81	35.15	14.24	0.00	5.10	0.82	0.25	1.01

### **Other Probe Parameters**

Sensor Arrangement	Triangular
Connector Angle	-47.0°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3–4 mm for an Area Scan job.

February 07, 2025

## Parameters of Probe: EX3DV4 - SN:3990

## Calibration Parameter Determined in Head Tissue Simulating Media

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> (k = 2)
750	41.9	0.89	9.29	10.11	9.10	0.37	1.27	±11.0%
900	41.5	0.97	8.87	9.65	8.69	0.37	1.27	±11.0%
1640	40.2	1.31	7.86	8.54	7.70	0.36	1.27	±11.0%
1750	40.1	1.37	7.89	8.58	7.73	0.36	1.27	±11.0%
1900	40.0	1.40	7.51	8.17	7.35	0.36	1.27	±11.0%
2100	39.8	1.49	7.39	8.04	7.24	0.36	1.27	±11.0%
2300	39.5	1.67	7.19	7.82	7.04	0.36	1.27	±11.0%
2450	39.2	1.80	6.94	7.55	6.80	0.36	1.27	±11.0%
2600	39.0	1.96	6.95	7.56	6.81	0.36	1.27	±11.0%
3300	38.2	2.71	6.44	7.00	6.31	0.35	1.27	±13.1%
3500	37.9	2.91	6.58	7.16	6.45	0.35	1.27	±13.1%
3700	37.7	3.12	6.46	7.03	6.33	0.35	1.27	±13.1%
3900	37.5	3.32	6.51	7.08	6.38	0.35	1.27	±13.1%
4100	37.2	3.53	6.45	7.02	6.32	0.34	1.27	±13.1%
4200	37.1	3.63	6.34	6.89	6.21	0.34	1.27	±13.1%
4400	36.9	3.84	6.16	6.70	6.03	0.34	1.27	±13.1%
4600	36.7	4.04	6.18	6.72	6.05	0.34	1.27	±13.1%
4800	36.4	4.25	6.30	6.85	6.17	0.34	1.27	±13.1%
4950	36.3	4.40	6.18	6.72	6.06	0.33	1.27	±13.1%
5250	35.9	4.71	5.44	5.92	5.33	0.30	1.27	±13.1%
5600	35.5	5.07	5.11	5.56	5.00	0.27	1.27	±13.1%
5750	35.4	5.22	4.94	5.37	4.84	0.26	1.27	±13.1%
5850	35.2	5.32	4.97	5.40	4.86	0.25	1.27	±13.1%

<sup>&</sup>lt;sup>C</sup> Frequency validity above 300 MHz of  $\pm 100$  MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to  $\pm 50$  MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is  $\pm 10$ , 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to  $\pm 110$  MHz.

F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 5\%$  from the target values (typically better than  $\pm 3\%$ )

F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 5\%$  from the target values (typically better than  $\pm 3\%$ ) and are valid for TSL with deviations of up to  $\pm 10\%$  if SAR correction is applied.

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

EX3DV4 - SN:3990 February 07, 2025

### Parameters of Probe: EX3DV4 - SN:3990

# Calibration Parameter Determined in Head Tissue Simulating Media

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> (k = 2)
6500	34.5	6.07	5.23	5.69	5.12	0.20	1.27	±18.6%

<sup>&</sup>lt;sup>C</sup> Frequency validity at 6.5 GHz is -600/+700 MHz, and ±700 MHz at or above 7 GHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

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The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 10\%$  from the target values (typically better than  $\pm 6\%$ ) and are valid for TSL with deviations of up to  $\pm 10\%$ 

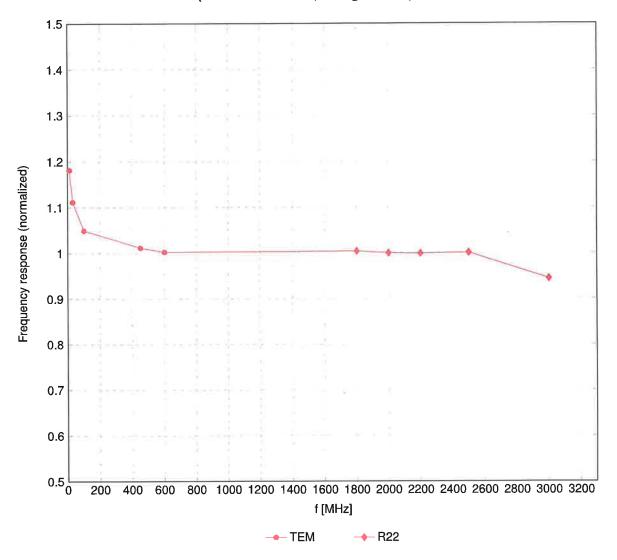
and are valid for TSL with deviations of up to  $\pm 10\%$ .

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than  $\pm 1\%$  for frequencies below 3 GHz; below  $\pm 2\%$  for frequencies between 3–6 GHz; and below  $\pm 4\%$  for frequencies between 6–10 GHz at any distance larger than half the probe tip diameter from the boundary.

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

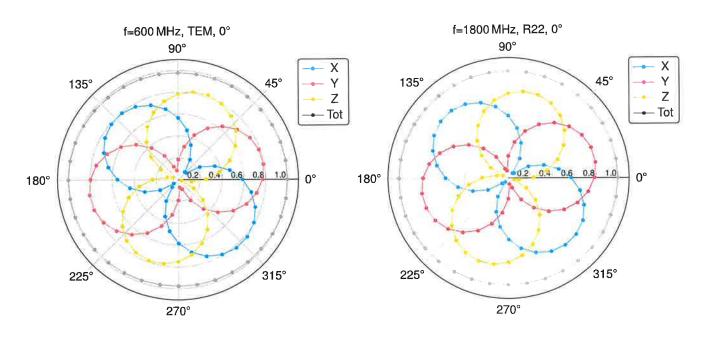
# Frequency Response of E-Field

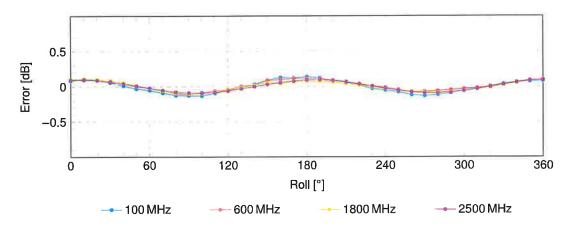
(TEM-Cell:ifi110 EXX, Waveguide:R22)



Uncertainty of Frequency Response of E-field: ±6.3% (k=2)

# Receiving Pattern ( $\phi$ ), $\theta = 0^{\circ}$

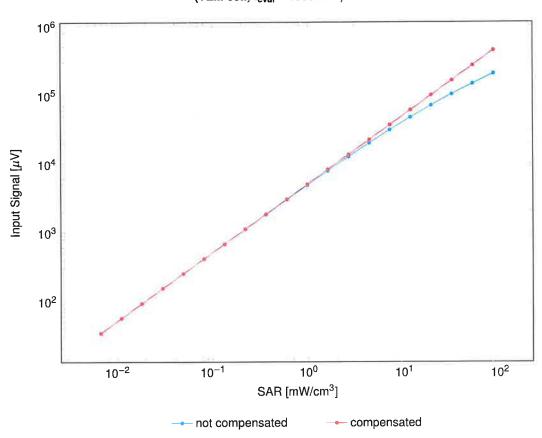


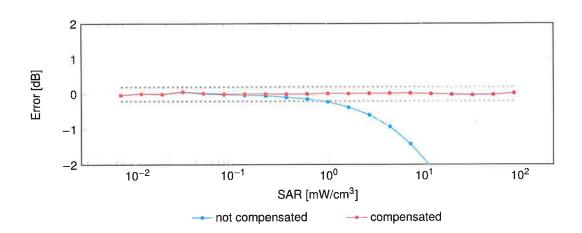


Uncertainty of Axial Isotropy Assessment: ±0.5% (k=2)

# Dynamic Range f(SAR<sub>head</sub>)

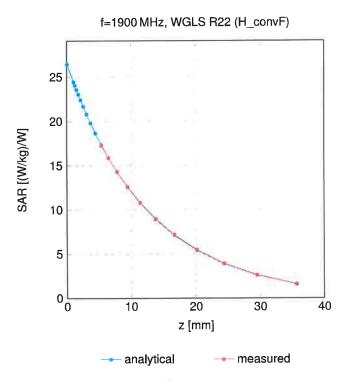
(TEM cell,  $f_{eval} = 1900\,\text{MHz})$ 



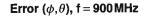


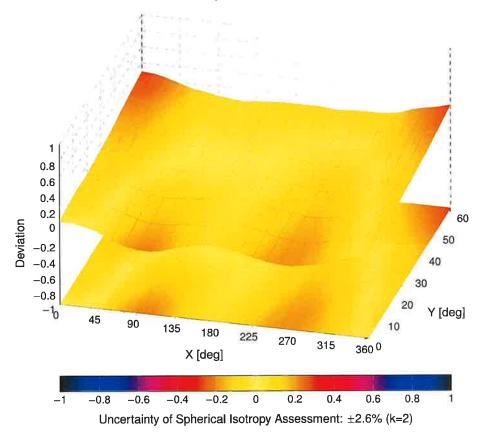
Uncertainty of Linearity Assessment:  $\pm 0.6\%$  (k=2)

## **Conversion Factor Assessment**



## **Deviation from Isotropy in Liquid**





Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
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S Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client

UL

Fremont, USA

Certificate No.

EX-7915\_Mar25

### **CALIBRATION CERTIFICATE**

Object

EX3DV4 - SN:7915

Calibration procedure(s)

QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6,

QA CAL-25.v8

Calibration procedure for dosimetric E-field probes

Calibration date

March 21, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22\pm3)^{\circ}$ C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched, Cal.
Power Sensor R&S NRP-33T	SN: 100967	28-Mar-24 (No. 217-04038)	Mar-25
Short [S6019i] + Attenuator [S6020i]	SN: L1119	26-Mar-24 (No. 217-04048)	Mar-25
OCP DAK-12	SN: 1016	24-Sept-24 (No. OCP-DAK12-1016_Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sept-24 (No. OCP-DAK3.5-1249_Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4	SN: 1301	07-Nov-24 (No. DAE4-1301_Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched. Check
ACAP 2020 Calibration Box	SN: L1404	30-Sept-24 (No. Report_ACAP2020E-Cave_20240930s)	Sep-25

Name

Function

Signature

Calibrated by

Aidonia Georgiadou

Laboratory Technician

5.0

Approved by

Sven Kühn

Technical Manager

Issued: March 26, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

#### Glossary

TSL

tissue simulating liquid

NORMx,y,z

sensitivity in free space

ConvF

sensitivity in TSL / NORMx,y,z

DCP

diode compression point

CF

crest factor (1/duty\_cycle) of the RF signal

A, B, C, D

modulation dependent linearization parameters

Polarization  $\varphi$ 

 $\varphi$  rotation around probe axis

Polarization  $\hat{\vartheta}$ 

 $\vartheta$  rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e.,  $\vartheta = 0$  is

normal to probe axis

Connector Angle

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information used in DASY system to align probe sensor X to the robot coordinate system

#### Calibration is Performed According to the Following Standards:

- a) IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- b) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

#### Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization ∂ = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not affect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z \* frequency\_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvE
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ±50 MHz to ±100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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EX3DV4 - SN:7915 March 21, 2025

# Parameters of Probe: EX3DV4 - SN:7915

#### **Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc $(k=2)$
Norm $(\mu V/(V/m)^2)$ A	0.65	0.58	0.61	±10.1%
DCP (mV) B	104.2	105.9	107.1	±4.7%

### **Calibration Results for Modulation Response**

UID	Communication System Name		A dB	${\sf B}$ ${\sf dB}\sqrt{\mu {\sf V}}$	С	D dB	VR mV	Max dev.	Max Unc <sup>E</sup>
			ив	υБ√μν		ub	1114	uev.	k=2
0	CW	X	0.00	0.00	1.00	0.00	122.3	±0.9%	±4.7%
		Y	0.00	0.00	1.00		146.4		
		Z	0.00	0.00	1.00		146.7		
10352	Pulse Waveform (200Hz, 10%)	X	1.48	60.42	6.34	10.00	60.0	±2.5%	±9.6%
		Y	1.48	60.40	6.22		60.0		
		Z	1.65	61.14	6.51		60.0		
10353	Pulse Waveform (200Hz, 20%)	X	44.00	80.00	11.00	6.99	80.0	±2.3%	±9.6%
	, , ,	Y	0.81	60.00	4.86		80.0		
		Z	22.00	74.00	9.00		80.0		
10354	Pulse Waveform (200Hz, 40%)	X	0.07	130.69	0.59	3.98	95.0	±2.4%	±9.6%
.000,	(2001)	Y	0.08	127.37	0.08		95.0		
		Z	78.00	74.00	7.00		95.0		
10355	Pulse Waveform (200Hz, 60%)	X	7.84	159.57	15.11	2.22	120.0	±1.6%	±9.6%
10000	1 4160 11410101111 (200112, 00011)	Y	0.38	60.00	2.51		120.0	İ	
		Z	9.80	127.52	4.55		120.0	i	
10387	QPSK Waveform, 1 MHz	X	0.57	62.99	12.01	1.00	150.0	±3.7%	±9.6%
,000.	<b></b>	Y	0.55	62.72	11.56	1	150.0	İ	
		Z	0.74	66.95	14.01		150.0	i	
10388	QPSK Waveform, 10 MHz	X	1.33	65.14	13.64	0.00	150.0	±1.2%	±9.6%
10000		Y	1.30	64.88	13.32		150.0	j	
		Z	1.51	67.24	14.83	1	150.0		
10396	64-QAM Waveform, 100 kHz	X	1.59	63.31	15.44	3.01	150.0	±1.1%	±9.6%
70000		Y	1.66	63.98	15.52	1	150.0	1	1
		Z	1.78	65.60	16.57		150.0		
10399	64-QAM Waveform, 40 MHz	X	2.82	65.87	14.90	0.00	150.0	±1.8%	±9.6%
		Y	2.80	65.87	14.80	1	150.0	1	
		Z	2.95	66.82	15.43		150.0		
10414	WLAN CCDF, 64-QAM, 40 MHz	X	3.99	66.34	15.48	0.00	150.0	±3.2%	±9.6%
		Y	3.81	65.64	15.04	1	150.0	1	
		Z	3.98	66.32	15.53		150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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A The uncertainties of Norm X,Y,Z do not affect the E2-field uncertainty inside TSL (see Page 5).

B Linearization parameter uncertainty for maximum specified field strength.

E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

March 21, 2025

# Parameters of Probe: EX3DV4 - SN:7915

### **Sensor Model Parameters**

	C1 fF	C2 fF	α V <sup>-1</sup>	T1 ms V <sup>-2</sup>	T2 ms V <sup>-1</sup>	T3 ms	T4 V <sup>-2</sup>	T5 V <sup>-1</sup>	Т6
X	10.5	76.64	33.89	1.64	0.00	4.90	0.12	0.02	1.00
V	10.3	74.38	33.46	2.90	0.00	4.90	0.41	0.00	1.00
Z	11.1	79.49	33.10	3.30	0.00	4.90	0.51	0.00	1.00

### **Other Probe Parameters**

Sensor Arrangement	Triangular
Connector Angle	-3.7°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3-4 mm for an Area Scan job.

EX3DV4 - SN:7915 March 21, 2025

## Parameters of Probe: EX3DV4 - SN:7915

#### Calibration Parameter Determined in HSL

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> (k = 2)
750	41.9	0.89	9.54	9.48	9.60	0.35	1.27	±11.0%
900	41.5	0.97	9.21	9.16	9.27	0.35	1.27	±11.0%
1750	40.1	1.37	8.01	7.96	8.06	0.34	1.27	±11.0%
1900	40.0	1.40	7.75	7.71	7.81	0.34	1.27	±11.0%
2300	39.5	1.67	7.35	7.31	7.40	0.33	1.27	±11.0%
2450	39.2	1.80	7.20	7.16	7.25	0.33	1.27	±11.0%
2600	39.0	1.96	7.06	7.02	7.11	0.33	1.27	±11.0%
5250	35.9	4.71	5.87	5.83	5.91	0.29	1.27	±13.1%
5600	35.5	5.07	5.34	5.31	5.38	0.27	1.27	±13.1%
5750	35.4	5.22	5.52	5.49	5.56	0.26	1.27	±13.1%

C Frequency validity above 300 MHz of ±100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ±50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ±10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to ±110 MHz.

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assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to  $\pm 110$  MHz.

The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 5\%$  from the target values (typically better than  $\pm 3\%$ ) and are valid for TSL, with deviations of up to  $\pm 10\%$  if SAB correction is applied.

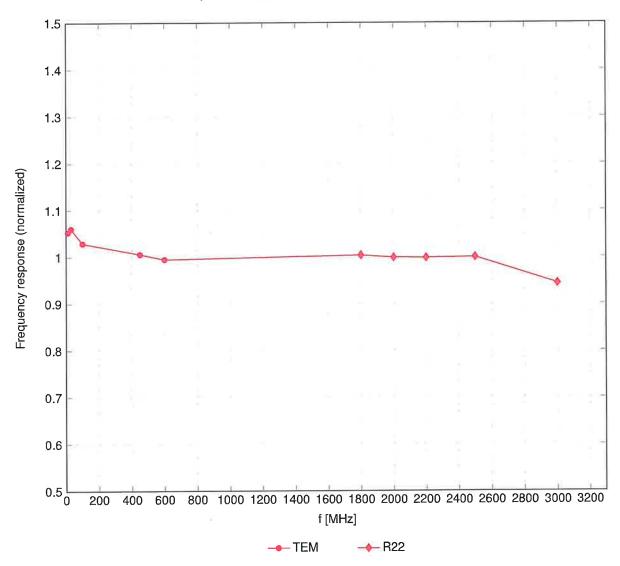
and are valid for TSL with deviations of up to ±10% if SAR correction is applied.

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

# Frequency Response of E-Field

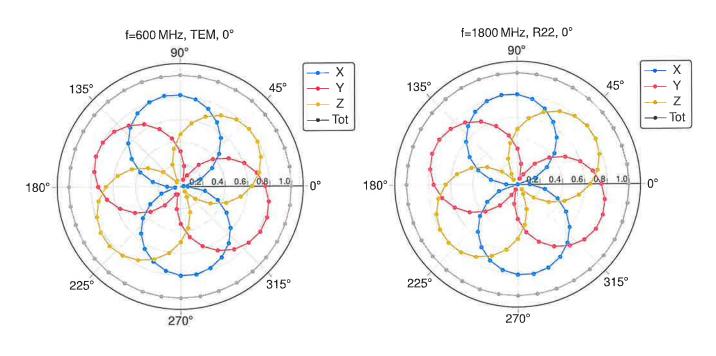
(TEM-Cell:ifi110 EXX, Waveguide:R22)

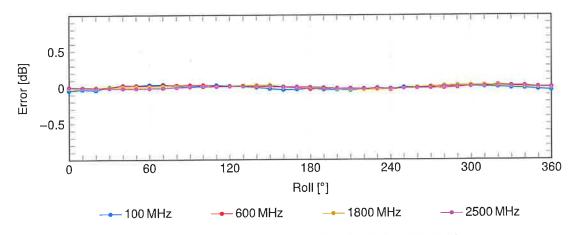


Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  (k=2)

March 21, 2025

# Receiving Pattern ( $\phi$ ), $\theta = 0^{\circ}$

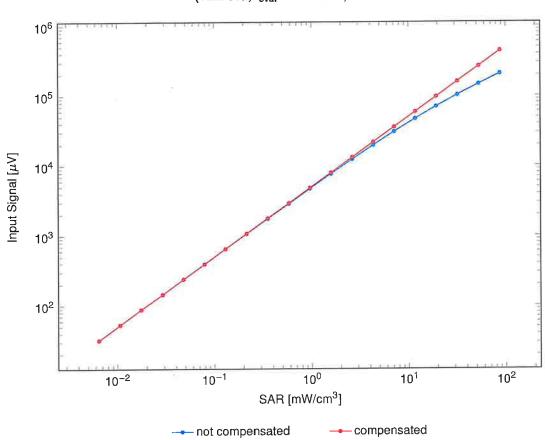


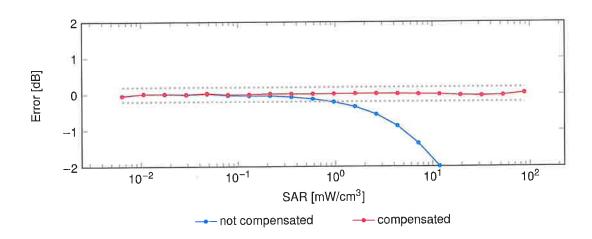


Uncertainty of Axial Isotropy Assessment: ±0.5% (k=2)

# $\textbf{Dynamic Range f}(\textbf{SAR}_{\textbf{HSL}})$

(TEM cell,  $f_{eval} = 1900\,\text{MHz})$ 

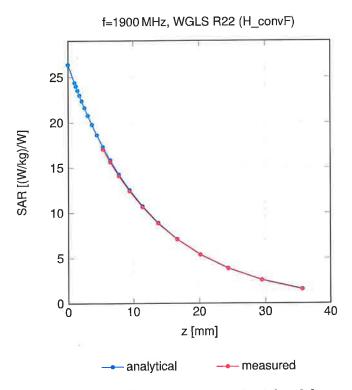




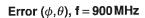
Uncertainty of Linearity Assessment: ±0.6% (k=2)

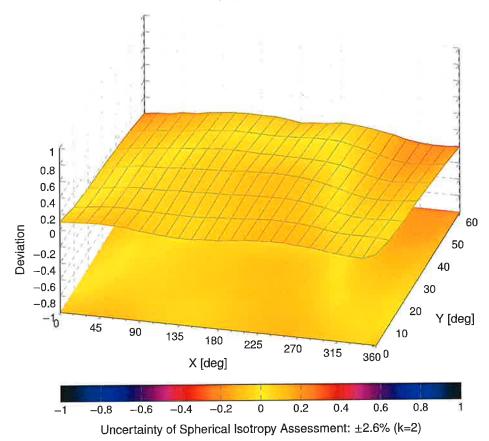
EX3DV4 - SN:7915 March 21, 2025

## **Conversion Factor Assessment**



# **Deviation from Isotropy in Liquid**





Schmid & Partner Engineering AG







S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura

S Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Client

ŲL

Fremont, USA

Certificate No.

EX-7808\_Mar25

## **CALIBRATION CERTIFICATE**

Object

EX3DV4 - SN:7808

Calibration procedure(s)

QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6,

QA CAL-25.v8

Calibration procedure for dosimetric E-field probes

Calibration date

March 12, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature ( $22 \pm 3$ )  $^{\circ}$ C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched, Cal.
Power Sensor R&S NRP-33T	SN: 100967	28-Mar-24 (No. 217-04038)	Mar-25
Short [S6019i] + Attenuator [S6020i]	SN: L1119	26-Mar-24 (No. 217-04048)	Mar-25
OCP DAK-12	SN: 1016	24-Sep-24 (No. OCP-DAK12-1016_Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sep-24 (No. OCP-DAK3.5-1249 Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349 Jan25)	Jan-26
DAE4	SN: 1301	07-Nov-24 (No. DAE4-1301_Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched, Check
ACAP 2020 Calibration Box	SN: L1404	30-Sep-24 (No. Report_ACAP2020E-Cave_20240930s)	

Name

Function

Signature

Calibrated by

Krešimir Franjić

Laboratory Technician

Approved by

Sven Kühn

Technical Manager

Issued: March 12, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: EX-7808\_Mar25

Page 1 of 23

Schmid & Partner **Engineering AG** 

Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage

Servizio svizzero di taratura

S Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

#### Glossary

**TSL** tissue simulating liquid NORMx,y,z sensitivity in free space ConvF sensitivity in TSL / NORMx,y,z

DCP diode compression point

CF crest factor (1/duty cycle) of the RF signal A, B, C, D modulation dependent linearization parameters

Polarization  $\varphi$  $\varphi$  rotation around probe axis

Polarization ∂  $\vartheta$  rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e.,  $\vartheta = 0$  is

normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

### Calibration is Performed According to the Following Standards:

a) IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices – Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.

b) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

#### Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization  $\vartheta = 0$  ( $f \le 900\,\text{MHz}$  in TEM-cell;  $f > 1800\,\text{MHz}$ : R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not affect the E2-field uncertainty inside TSL (see below ConvF).
- NORM(f)x, y, z = NORMx, y, z \* frequency response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- · ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \le 800 \,\mathrm{MHz}$ ) and inside waveguide using analytical field distributions based on power measurements for  $f > 800 \,\mathrm{MHz}$ . The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: EX-7808\_Mar25 Page 2 of 23 EX3DV4 - SN:7808 March 12, 2025

### Parameters of Probe: EX3DV4 - SN:7808

#### **Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc (k = 2)
Norm $(\mu V/(V/m)^2)$ A	0.61	0.70	0.70	±10.1%
DCP (mV) B	108.4	103.9	104.3	±4.7%

### **Calibration Results for Modulation Response**

UID	Communication System Name		A	B B	С	D	VR	Max	Max
			dB	dB√μV		dB	mV	dev.	Unc <sup>E</sup> k = 2
0	CW	X	0.00	0.00	1.00	0.00	145.5	±1.5%	±4.7%
		Y	0.00	0.00	1.00		132.8	İ	
		Z	0.00	0.00	1.00		128.4		
10352	Pulse Waveform (200Hz, 10%)	X	2.00	62.00	7.00	10.00	60.0	±2.9%	±9.6%
		Y	1.57	60.77	6.45		60.0		
		Z	1.61	61.02	6.60		60.0		
10353	Pulse Waveform (200Hz, 20%)	X	10.00	72.00	9.00	6.99	80.0	±2.1%	±9.6%
		Y	0.78	60.00	4.85		80.0		
		Z	0.78	60.00	4.92		80.0		
10354	Pulse Waveform (200Hz, 40%)	X	0.40	60.00	4.01	3.98	95.0	±2.4%	±9.6%
		Y	0.00	125.12	0.64		95.0		
		Z	0.28	152.25	1.36		95.0		
10355	Pulse Waveform (200Hz, 60%)	X	11.26	91.99	0.54	2.22	120.0	±1.7%	±9.6%
		Y	6.17	159.97	2.70		120.0		
		Z	8.18	123.15	10.14		120.0		
10387	QPSK Waveform, 1 MHz	X	0.51	64.72	13.70	1.00	150.0	±2.8%	±9.6%
		Y	0.51	62.94	12.03		150.0		
		Z	0.49	63.98	13.14		150.0		
10388	QPSK Waveform, 10 MHz	X	1.31	67.33	14.10	0.00	150.0	±0.8%	±9.6%
		Y	1.29	65.45	13.60		150.0		
		Z	1.28	66.63	13.89		150.0		
10396	64-QAM Waveform, 100 kHz	X	1.77	65.29	16.19	3.01	150.0	±1.4%	±9.6%
		Y	1.66	64.07	15.53		150.0		
		Z	1.54	63.29	15.55		150.0		
10399	64-QAM Waveform, 40 MHz	Х	2.79	67.10	15.42	0.00	150.0	±1.4%	±9.6%
		Y	2.79	66.11	14.99		150.0		
		Z	2.76	66.66	15.29		150.0		
10414	WLAN CCDF, 64-QAM, 40 MHz	X	3.64	66.72	15.38	0.00	150.0	±2.4%	±9.6%
		Y	3.75	65.83	15.15		150.0		
		Z	3.62	66.25	15.27		150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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 $<sup>^{\</sup>rm A}$  The uncertainties of Norm X,Y,Z do not affect the E $^{\rm 2}$ -field uncertainty inside TSL (see Pages 5 to 7).  $^{\rm B}$  Linearization parameter uncertainty for maximum specified field strength.

E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

EX3DV4 - SN:7808

## Parameters of Probe: EX3DV4 - SN:7808

#### **Sensor Model Parameters**

	C1 fF	C2 fF	α V <sup>-1</sup>	T1 ms V <sup>-2</sup>	T2 msV <sup>-1</sup>	T3 ms	T4 V <sup>-2</sup>	T5 V <sup>-1</sup>	T6
х	6.8	48.19	32.24	2.78	0.00	4.90	0.51	0.00	1.00
У	9.2	66.87	33.66	1.24	0.00	4.90	0.48	0.00	1.00
Z	7.4	53.66	33.78	1.85	0.00	4.90	0.00	0.01	1.00

### **Other Probe Parameters**

Sensor Arrangement	Triangular
Connector Angle	4.4°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3-4 mm for an Area Scan job.

Certificate No: EX-7808\_Mar25

EX3DV4 - SN:7808

## Parameters of Probe: EX3DV4 - SN:7808

#### Calibration Parameter Determined in HSL

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> (k = 2)
6	55.0	0.75	18.51	18.83	17.73	0.00	1.25	±13.3%
13	55.0	0.75	18.27	18.58	17.50	0.00	1.25	±13.3%
30	55.0	0.75	16.78	17.06	16.06	0.00	1.25	±13.3%
64	54.2	0.75	14.41	14.65	13.79	0.00	1.25	±13.3%
450	43.5	0.87	10.91	10.91	10.91	0.16	1.30	±13.3%
750	41.9	0.89	9.80	9.74	9.36	0.37	1.27	±11.0%
900	41.5	0.97	9.43	9.37	9.01	0.37	1.27	±11.0%
1450	40.5	1.20	8.36	8.31	7.99	0.36	1.27	±11.0%
1640	40.2	1.31	8.21	8.16	7.85	0.36	1.27	±11.0%
1750	40.1	1.37	8.07	8.02	7.71	0.36	1.27	±11.0%
1900	40.0	1.40	7.88	7.84	7.53	0.36	1.27	±11.0%
2100	39.8	1.49	7.69	7.64	7.34	0.36	1.27	±11.0%
2300	39.5	1.67	7.48	7.44	7.15	0.36	1.27	±11.0%
2450	39.2	1.80	7.32	7.27	6.99	0.36	1.27	±11.0%
2600	39.0	1.96	7.16	7.12	6.84	0.36	1.27	±11.0%
3300	38.2	2.71	6.61	6.57	6.32	0.35	1.27	±13.1%
3500	37.9	2.91	6.52	6.48	6.23	0.35	1.27	±13.1%
3700	37.7	3.12	6.45	6.41	6.16	0.35	1.27	±13.1%
3900	37.5	3.32	6.40	6.36	6.11	0.35	1.27	±13.1%
4100	37.2	3.53	6.30	6.27	6.02	0.35	1.27	±13.1%
4200	37.1	3.63	6.25	6.21	5.97	0.35	1.27	±13.1%
4400	36.9	3.84	6.16	6.12	5.88	0.35	1.27	±13.1%
4600	36.7	4.04	6.06	6.02	5.79	0.34	1.27	±13.1%
4800	36.4	4.25	6.00	5.96	5.73	0.34	1.27	±13.1%
4950	36.3	4.40	5.88	5.85	5.62	0.33	1.27	±13.1%
5250	35.9	4.71	5.68	5.65	5.43	0.30	1.27	±13.1%
5600	35.5	5.07	5.26	5.23	5.02	0.28	1.27	±13.1%
5750	35.4	5.22	5.36	5.33	5.12	0.26	1.27	±13.1%

<sup>&</sup>lt;sup>C</sup> Frequency validity above 300 MHz of ±100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ±50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ±10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to ±110 MHz.

Certificate No: EX-7808\_Mar25

assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to  $\pm 110$  MHz.

F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 5\%$  from the target values (typically better than  $\pm 3\%$ ) and are valid for TSL with deviations of up to  $\pm 10\%$  if SAR correction is applied.

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

# Parameters of Probe: EX3DV4 - SN:7808

## **Calibration Parameter Determined in HSL**

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> (k = 2)
5850	35.2	5.32	5.43	5.40	5.19	0.25	1.27	±13.1%

C Frequency validity above 300 MHz of ±100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ±50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ±10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to  $\pm 110$  MHz. F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 5\%$  from the target values (typically better than  $\pm 3\%$ )

and are valid for TSL with deviations of up to ±10% if SAR correction is applied.

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

March 12, 2025

## Parameters of Probe: EX3DV4 - SN:7808

#### **Calibration Parameter Determined in HSL**

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> (k = 2)
6500	34.5	6.07	5.37	5.34	5.13	0.20	1.27	±18.6%

C Frequency validity at 6.5 GHz is -600/+700 MHz, and ±700 MHz at or above 7 GHz. The uncertainty is the RSS of the ConvF uncertainty at calibration

frequency and the uncertainty for the indicated frequency band. F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 10\%$  from the target values (typically better than  $\pm 6\%$ )

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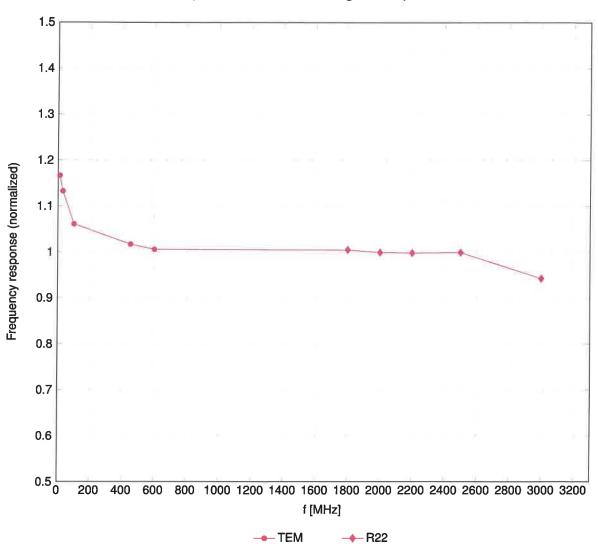
and are valid for TSL with deviations of up to  $\pm 10\%$ .

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz; below ±2% for frequencies between 3-6 GHz; and below ±4% for frequencies between 6-10 GHz at any distance larger than half the probe tip diameter from the boundary.

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

# Frequency Response of E-Field

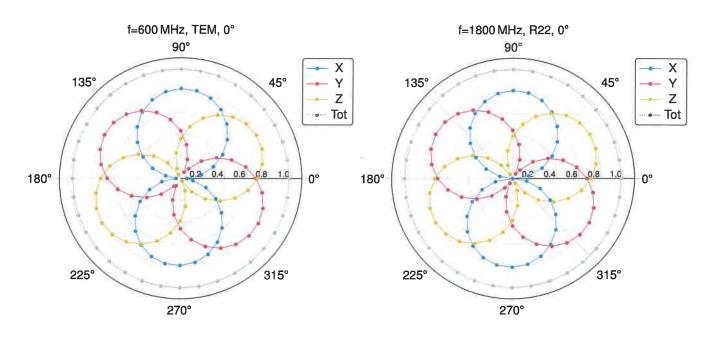
(TEM-Cell:ifi110 EXX, Waveguide:R22)

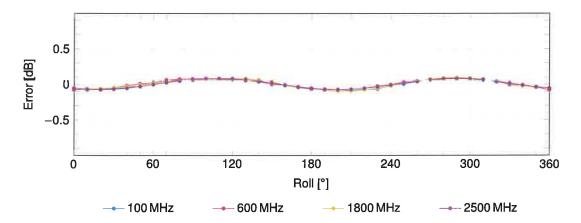


Uncertainty of Frequency Response of E-field: ±6.3% (k=2)

EX3DV4 - SN:7808 March 12, 2025

# Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$

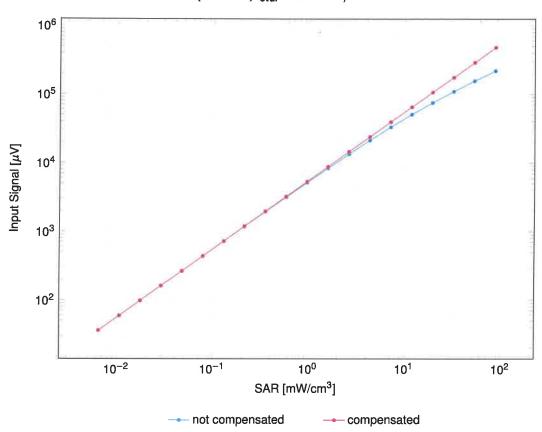


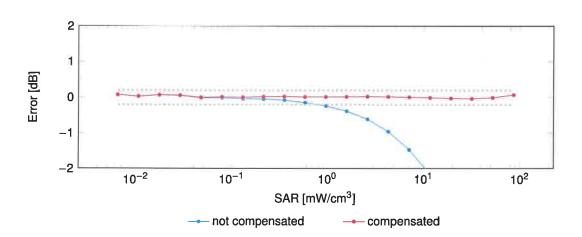


Uncertainty of Axial Isotropy Assessment: ±0.5% (k=2)

# Dynamic Range $f(SAR_{HSL})$

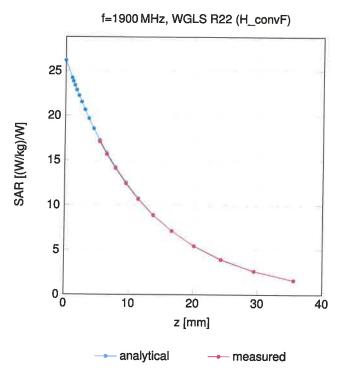
(TEM cell,  $f_{\text{eval}} = 1900\,\text{MHz})$ 





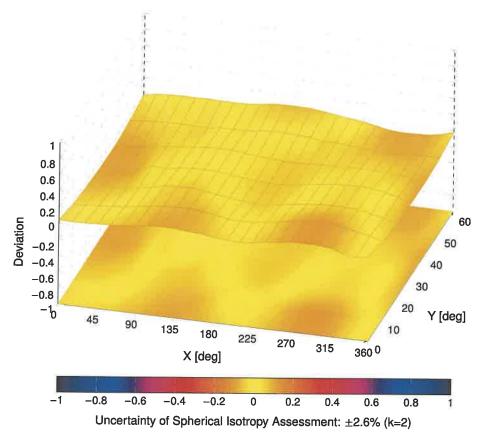
Uncertainty of Linearity Assessment: ±0.6% (k=2)

# **Conversion Factor Assessment**



# **Deviation from Isotropy in Liquid**

Error  $(\phi, \theta)$ , f = 900 MHz



### Calibration Laboratory of Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
Service suisse d'étalonnage
Servizio svizzero di taratura

Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Client

UL

Fremont, USA

Certificate No.

EX-3902\_Mar25

## **CALIBRATION CERTIFICATE**

Object

EX3DV4 - SN:3902

Calibration procedure(s)

QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6,

QA CAL-25.v8

Calibration procedure for dosimetric E-field probes

Calibration date

March 10, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22\pm3)$  °C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched, Cal.
Power Sensor R&S NRP-33T	SN: 100967	28-Mar-24 (No. 217-04038)	Mar-25
Short [S6019i] + Attenuator [S6020i]	SN: L1119	26-Mar-24 (No. 217-04048)	Mar-25
OCP DAK-12	SN: 1016	24-Sep-24 (No. OCP-DAK12-1016 Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sep-24 (No. OCP-DAK3.5-1249 Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4	SN: 1301	07-Nov-24 (No. DAE4-1301 Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched, Check
ACAP 2020 Calibration Box	SN: L1404	30-Sep-24 (No. Report_ACAP2020E-Cave_20240930s)	

Name

Function

Signature

Calibrated by

Joanna Lleshaj

Laboratory Technician

Approved by

Sven Kühn

Technical Manager

Issued: March 10, 2025

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Certificate No: EX-3902\_Mar25

Page 1 of 22

### **Calibration Laboratory of**

Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland





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Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

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#### Glossary

TSL tissue simulating liquid NORMx,y,z sensitivity in free space

ConvF sensitivity in TSL / NORMx,y,z
DCP diode compression point

CF crest factor (1/duty\_cycle) of the RF signal A, B, C, D modulation dependent linearization parameters

Polarization  $\varphi$   $\varphi$  rotation around probe axis

Polarization  $\vartheta$  rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e.,  $\vartheta = 0$  is

normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

#### Calibration is Performed According to the Following Standards:

a) IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices – Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.

b) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

#### **Methods Applied and Interpretation of Parameters:**

- NORMx,y,z: Assessed for E-field polarization θ = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not affect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z \* frequency\_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP
  does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of
  power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum
  calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ±50 MHz to ±100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- · Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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EX3DV4 - SN:3902

## Parameters of Probe: EX3DV4 - SN:3902

### **Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc (k = 2)
Norm $(\mu V/(V/m)^2)$ A	0.43	0.45	0.47	±10.1%
DCP (mV) B	104.5	100.6	101.5	±4.7%

### **Calibration Results for Modulation Response**

UID	Communication System Name		A dB	$dB\sqrt{\mu V}$	С	D dB	VR mV	Max dev.	Max Unc <sup>E</sup> k = 2
0	CW	X	0.00	0.00	1.00	0.00	144.7	±0.8%	±4.7%
		Υ	0.00	0.00	1.00		121.0		/0
		Z	0.00	0.00	1.00		146.1	1	
10352	Pulse Waveform (200Hz, 10%)	X	20.00	93.04	22.24	10.00	60.0	±3.1%	±9.6%
		Y	64.00	106.00	25.00		60.0		
		Z	20.00	94.17	22.82		60.0		
10353	Pulse Waveform (200Hz, 20%)	X	20.00	95.16	22.31	6.99	80.0	±1.3%	±9.6%
		Y	20.00	93.47	20.91		80.0		
		Z	20.00	96.80	23.25		80.0	1	
10354	Pulse Waveform (200Hz, 40%)	X	20.00	101.30	24.02	3.98	95.0	±1.4%	±9.6%
		Y	20.00	96.93	21.11		95.0		
		Z	20.00	98.53	22.78		95.0	1	
10355	Pulse Waveform (200Hz, 60%)	X	20.00	110.48	27.02	2.22	120.0	±1.4%	±9.6%
		Y	20.00	101.53	21.96		120.0		
		Z	20.00	105.10	24.65		120.0	-	
10387	QPSK Waveform, 1 MHz	X	1.72	67.09	15.49	1.00	150.0	±1.7%	±9.6%
		Y	1.62	64.98	14.34		150.0		
		Z	1.81	66.73	15.56		150.0	ľ	
10388	QPSK Waveform, 10 MHz	X	2.27	68.60	16.12	0.00	150.0	±1.0%	±9.6%
		Y	2.13	66.82	15.02		150.0		
		Z	2.42	69.01	16.29		150.0		
10396	64-QAM Waveform, 100 kHz	X	2.79	70.26	18.68	3.01	150.0	±0.7%	±9.6%
		Y	2.84	69.55	18.23		150.0		
		Z	2.93	69.98	18.62		150.0		
10399	64-QAM Waveform, 40 MHz	X	3.55	67.50	15.98	0.00	150.0	±0.8%	±9.6%
		Y	3.48	66.73	15.48	İ	150.0		
		7	3.52	67.05	15.80	ŀ	150.0		
10414	WLAN CCDF, 64-QAM, 40 MHz	X	4.70	65.35	15.36	0.00	150.0	±1.8%	±9.6%
		Y	4.69	64.83	15.04	1	150.0		
		Z	4.88	65.50	15.49		150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

A The uncertainties of Norm X,Y,Z do not affect the E<sup>2</sup>-field uncertainty inside TSL (see Pages 5 and 6).

B Linearization parameter uncertainty for maximum specified field strength.

E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

March 10, 2025

# Parameters of Probe: EX3DV4 - SN:3902

#### **Sensor Model Parameters**

	C1 fF	C2 fF	α V <sup>-1</sup>	T1 ms V <sup>-2</sup>	T2 msV <sup>-1</sup>	T3 ms	T4 V <sup>-2</sup>	T5 V <sup>-1</sup>	Т6
х	41.6	302.02	33.91	18.63	0.13	5.10	1.21	0.17	1.01
v	47.2	350.28	35.03	11.50	0.39	5.05	1.15	0.25	1.01
z	50.3	372.68	35.14	21.75	0.18	5.10	0.55	0.37	1.01

### **Other Probe Parameters**

Sensor Arrangement	Triangular
Connector Angle	4.0°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3-4 mm for an Area Scan job.

Certificate No: EX-3902\_Mar25

March 10, 2025

### Parameters of Probe: EX3DV4 - SN:3902

#### **Calibration Parameter Determined in HSL**

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> (k = 2)
2450	39.2	1.80	8.17	7.71	7.26	0.31	1.27	±11.0%
5250	35.9	4.71	5.93	5.59	5.27	0.28	1.27	±13.1%
5600	35.5	5.07	5.49	5.18	4.88	0.26	1.27	±13.1%
5750	35.4	5.22	5.56	5.25	4.94	0.25	1.27	±13.1%
5850	35.2	5.32	5.60	5.28	4.98	0.24	1.27	±13.1%

<sup>&</sup>lt;sup>C</sup> Frequency validity above 300 MHz of  $\pm 100$  MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to  $\pm 50$  MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is  $\pm 10$ , 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to  $\pm 110$  MHz.

F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 5\%$  from the target values (typically better than  $\pm 3\%$ )

F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 5\%$  from the target values (typically better than  $\pm 3\%$ ) and are valid for TSL with deviations of up to  $\pm 10\%$  if SAR correction is applied.

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

EX3DV4 - SN:3902 March 10, 2025

## Parameters of Probe: EX3DV4 - SN:3902

### **Calibration Parameter Determined in HSL**

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> (k = 2)
6500	34.5	6.07	5.74	5.42	5.10	0.20	1.27	±18.6%

<sup>&</sup>lt;sup>C</sup> Frequency validity at 6.5 GHz is -600/+700 MHz, and ±700 MHz at or above 7 GHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Certificate No: EX-3902\_Mar25 Page 6 of 22

F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 10\%$  from the target values (typically better than  $\pm 6\%$ ) and are valid for TSL with deviations of up to  $\pm 10\%$ .

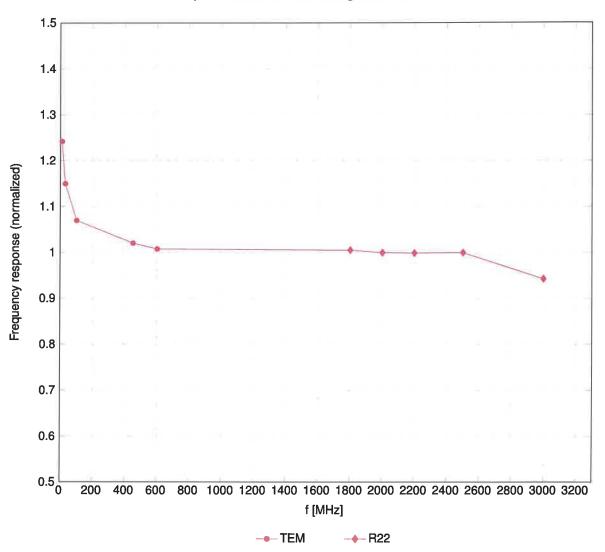
and are valid for TSL with deviations of up to ±10%.

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz; below ±2% for frequencies between 3–6 GHz; and below ±4% for frequencies between 6–10 GHz at any distance larger than half the probe tip diameter from the boundary.

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

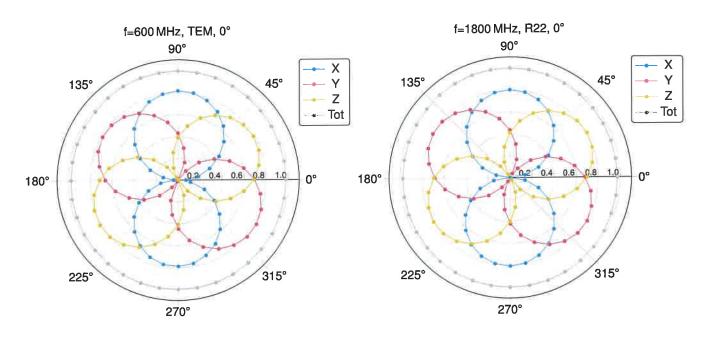
# Frequency Response of E-Field

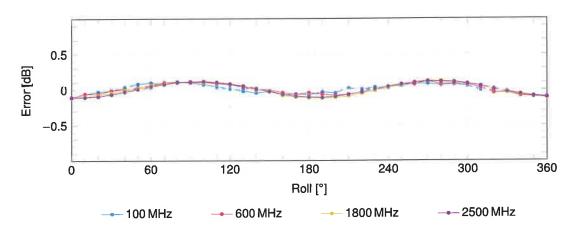
(TEM-Cell:ifi110 EXX, Waveguide:R22)



Uncertainty of Frequency Response of E-field: ±6.3% (k=2)

# Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$

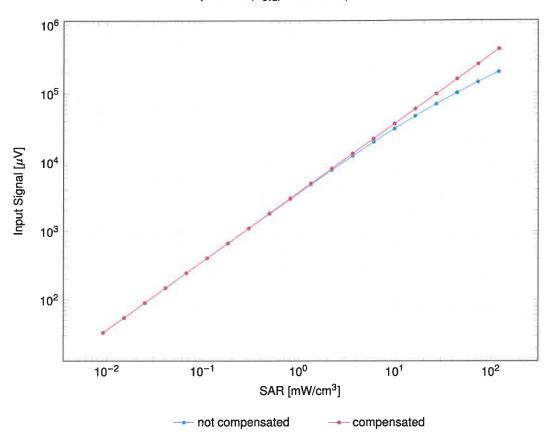


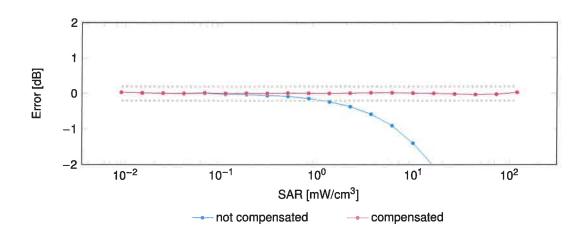


Uncertainty of Axial Isotropy Assessment: ±0.5% (k=2)

# $\textbf{Dynamic Range f}(\textbf{SAR}_{\textbf{HSL}})$

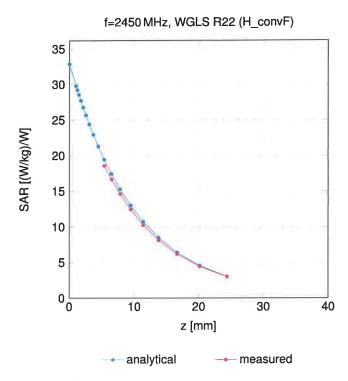
(TEM cell,  $f_{\text{eval}} = 1900\,\text{MHz})$ 



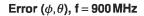


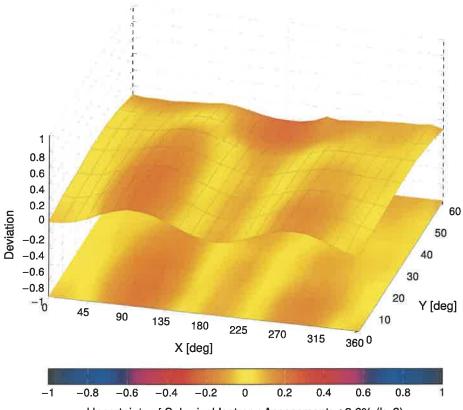
Uncertainty of Linearity Assessment: ±0.6% (k=2)

## **Conversion Factor Assessment**



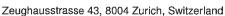
# **Deviation from Isotropy in Liquid**





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Client

UL

Fremont, USA

Certificate No.

EX-7335 Jan25

### **CALIBRATION CERTIFICATE**

Object

EX3DV4 - SN:7335

Calibration procedure(s)

QA CAL-01.v10, QA CAL-12.v10, QA CAL-14.v7, QA CAL-23.v6,

QA CAL-25.v8

Calibration procedure for dosimetric E-field probes

Calibration date

January 13, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3) ℃ and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched. Cal.
Power Sensor R&S NRP-33T	SN: 100967	28-Mar-24 (No. 217-04038)	Mar-25
Short [S6019i] + Attenuator [S6020i]	SN: L1119	26-Mar-24 (No. 217-04048)	Mar-25
OCP DAK-12	SN: 1016	24-Sept-24 (No. OCP-DAK12-1016_Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sept-24 (No. OCP-DAK3.5-1249_Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4	SN: 1301	07-Nov-24 (No. DAE4-1301_Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched. Check
ACAP 2020 Calibration Box	SN: L1404	30-Sept-24 (No. Report_ACAP2020E-Cave_20240930s)	Sep-25

Name Function Signature

Calibrated by Aidonia Georgiadou Laboratory Technician

Approved by Sven Kühn Technical Manager

Issued: January 13, 2025

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### Glossary

TSL tissue simulating liquid NORMx,y,z sensitivity in free space

ConvF sensitivity in TSL / NORMx,y,z

DCP diode compression point

CF crest factor (1/duty\_cycle) of the RF signal A, B, C, D modulation dependent linearization parameters

Polarization  $\varphi$   $\varphi$  rotation around probe axis

Polarization  $\vartheta$  or rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e.,  $\vartheta = 0$  is

normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

### Calibration is Performed According to the Following Standards:

a) IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices – Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.

b) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

### Methods Applied and Interpretation of Parameters:

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- NORM(f)x,y,z = NORMx,y,z \* frequency\_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ±50 MHz to ±100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis).
   No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: EX-7335\_Jan25 Page 2 of 22

EX3DV4 - SN:7335 January 13, 2025

### Parameters of Probe: EX3DV4 - SN:7335

#### **Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc (k = 2)
Norm $(\mu V/(V/m)^2)$ A	0.40	0.42	0.54	±10.1%
DCP (mV) B	104.6	102.2	99.1	±4.7%

#### **Calibration Results for Modulation Response**

UID	Communication System Name		A dB	B dB√μV	С	D dB	VR mV	Max dev.	Max Unc <sup>E</sup> k = 2
0	CW	X	0.00	0.00	1.00	0.00	134.8	±0.9%	±4.7%
		Y	0.00	0.00	1.00		145.2		
		Z	0.00	0.00	1.00		132.0		
10352	Pulse Waveform (200Hz, 10%)	X	6.79	75.38	14.23	10.00	60.0	±2.8%	±9.6%
		Y	8.73	79.99	16.99		60.0		
		Z	20.00	90.68	20.49		60.0		
10353	Pulse Waveform (200Hz, 20%)	X	20.00	86.85	16.80	6.99	80.0	±1.5%	±9.6%
		Y	20.00	90.32	18.88		80.0		
		Z	20.00	92.12	20.24		80.0		
10354	Pulse Waveform (200Hz, 40%)	X	20.00	92.35	18.28	3.98	95.0	±1.2%	±9.6%
		Y	20.00	93.76	19.02		95.0	1	
		Z	20.00	96.53	21.20		95.0		
10355	Pulse Waveform (200Hz, 60%)	X	20.00	108.49	24.63	2.22	120.0	±1.3%	±9.6%
		Y	20.00	100.26	20.81		120.0		
		Z	20.00	103.35	23.23		120.0		
10387	QPSK Waveform, 1 MHz	X	2.10	74.38	18.38		150.0	±2.3%	±9.6%
		Y	1.63	65.65	14.75		150.0		
		Z	1.79	66.07	15.28		150.0		
10388	QPSK Waveform, 10 MHz	X	2.20	70.02	17.15	0.00	150.0	±1.1%	±9.6%
		Y	2.14	67.28	15.41		150.0		
		Z	2.37	68.42	15.98		150.0		
10396	64-QAM Waveform, 100 kHz	X	1.92	65.71	16.67	3.01	150.0	±1.0%	±9.6%
		Y	2.79	70.22	18.66		150.0		
		Z	2.96	70.30	18.75		150.0		
10399	64-QAM Waveform, 40 MHz	X	3.43	67.83	16.32	0.00	150.0	±0.8%	±9.6%
		Y	3.48	66.90	15.65		150.0		
		Z	3.64	67.41	15.96		150.0		
10414	WLAN CCDF, 64-QAM, 40 MHz	X	4.58	66.21	15.89	0.00	150.0	±1.7%	±9.6%
		Y	4.85	65.62	15.48		150.0		
		Z	4.85	65.18	15.33		150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

A The uncertainties of Norm X,Y,Z do not affect the E2-field uncertainty inside TSL (see Pages 5 and 6).

<sup>&</sup>lt;sup>B</sup> Linearization parameter uncertainty for maximum specified field strength.

E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

EX3DV4 - SN:7335

## Parameters of Probe: EX3DV4 - SN:7335

### **Sensor Model Parameters**

	C1	C2	α	T1	T2	Т3	T4	T5	Т6
	fF	fF	V <sup>-1</sup>	ms V <sup>-2</sup>	msV <sup>−1</sup>	ms	V <sup>-2</sup>	V <sup>-1</sup>	
Х	24.4	175.23	33.34	11.37	0.00	5.00	0.38	0.10	1.00
у	43.7	321.67	34.60	7.12	0.45	4.99	1.70	0.09	1.01
Z	53.4	399.50	35.71	17.88	0.00	5.07	1.03	0.28	1.01

### **Other Probe Parameters**

Sensor Arrangement	Triangular
Connector Angle	-0.8°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	1.4 mm

Note: Measurement distance from surface can be increased to 3-4 mm for an Area Scan job.

January 13, 2025 EX3DV4 - SN:7335

### Parameters of Probe: EX3DV4 - SN:7335

### **Calibration Parameter Determined in Head Tissue Simulating Media**

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> (k = 2)
750	41.9	0.89	9.91	10.10	9.53	0.37	1.27	±11.0%
900	41.5	0.97	9.25	9.44	8.89	0.37	1.27	±11.0%
1450	40.5	1.20	8.12	8.28	7.81	0.37	1.27	±11.0%
1640	40.2	1.31	8.16	8.32	7.84	0.38	1.27	±11.0%
1750	40.1	1.37	8.15	8.31	7.84	0.38	1.27	±11.0%
1900	40.0	1.40	8.05	8.21	7.74	0.38	1.27	±11.0%
2100	39.8	1.49	7.67	7.83	7.38	0.38	1.27	±11.0%
2300	39.5	1.67	7.60	7.75	7.31	0.38	1.27	±11.0%
2450	39.2	1.80	7.33	7.48	7.05	0.38	1.27	±11.0%
2600	39.0	1.96	7.41	7.56	7.13	0.38	1.27	±11.0%
3300	38.2	2.71	6.90	7.04	6.64	0.39	1.27	±13.1%
3500	37.9	2.91	6.78	6.92	6.52	0.39	1.27	±13.1%
3700	37.7	3.12	6.86	7.00	6.60	0.39	1.27	±13.1%
3900	37.5	3.32	6.64	6.78	6.39	0.39	1.27	±13.1%
4100	37.2	3.53	6.52	6.65	6.27	0.39	1.27	±13.1%
4200	37.1	3.63	6.72	6.86	6.46	0.39	1.27	±13.1%
4400	36.9	3.84	6.35	6.47	6.10	0.39	1.27	±13.1%
4600	36.7	4.04	6.43	6.56	6.19	0.39	1.27	±13.1%
4800	36.4	4.25	6.31	6.44	6.07	0.39	1.27	±13.1%
4950	36.3	4.40	6.08	6.20	5.84	0.38	1.27	±13.1%
5250	35.9	4.71	5.92	6.04	5.70	0.34	1.27	±13.1%
5600	35.5	5.07	5.37	5.48	5.17	0.30	1.27	±13.1%
5750	35.4	5.22	5.42	5.53	5.21	0.29	1.27	±13.1%
5850	35.2	5.32	5.40	5.50	5.19	0.27	1.27	±13.1%

 $<sup>^{</sup>m C}$  Frequency validity above 300 MHz of  $\pm 100$  MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to  $\pm 50$  MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is  $\pm 10$ , 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4-9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to  $\pm 110$  MHz.

F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 5\%$  from the target values (typically better than  $\pm 3\%$ )

Certificate No: EX-7335\_Jan25

and are valid for TSL with deviations of up to ±10% if SAR correction is applied.

G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

January 13, 2025

# Parameters of Probe: EX3DV4 - SN:7335

### Calibration Parameter Determined in Head Tissue Simulating Media

f (MHz) <sup>C</sup>	Relative Permittivity <sup>F</sup>	Conductivity <sup>F</sup> (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha <sup>G</sup>	Depth <sup>G</sup> (mm)	Unc <sup>H</sup> ( <i>k</i> = 2)
6500	34.5	6.07	5.71	5.82	5.49	0.20	1.27	±18.6%

C Frequency validity at 6.5 GHz is -600/+700 MHz, and ±700 MHz at or above 7 GHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

F The probes are calibrated using tissue simulating liquids (TSL) that deviate for  $\varepsilon$  and  $\sigma$  by less than  $\pm 10\%$  from the target values (typically better than  $\pm 6\%$ )

and are valid for TSL with deviations of up to ±10%.

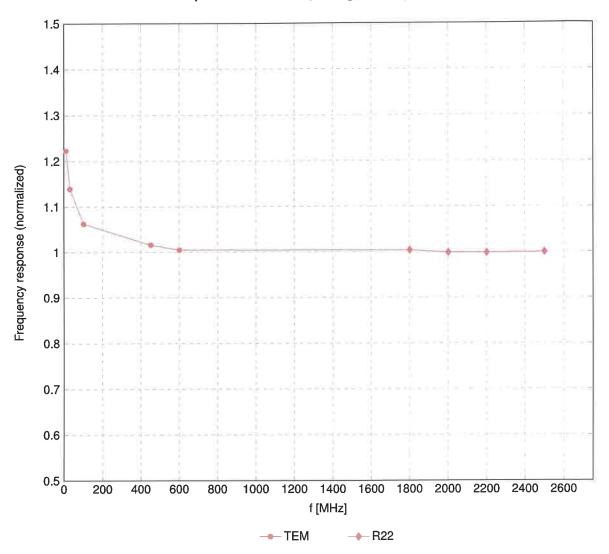
Galpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less. than ±1% for frequencies below 3 GHz; below ±2% for frequencies between 3-6 GHz; and below ±4% for frequencies between 6-10 GHz at any distance larger than half the probe tip diameter from the boundary.

H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

January 13, 2025

# **Frequency Response of E-Field**

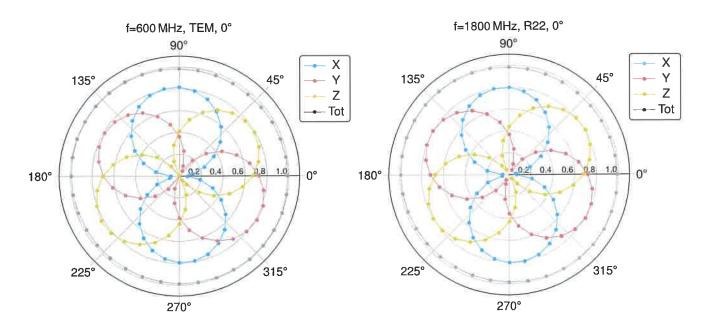
(TEM-Cell:ifi110 EXX, Waveguide:R22)

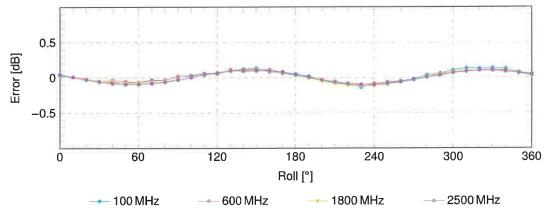


Uncertainty of Frequency Response of E-field: ±6.3% (k=2)

January 13, 2025

# Receiving Pattern ( $\phi$ ), $\theta = 0^{\circ}$

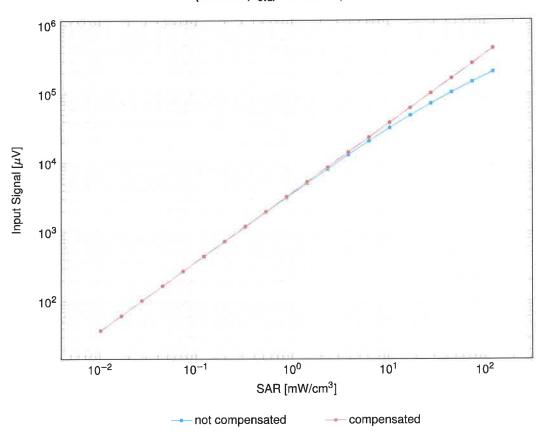


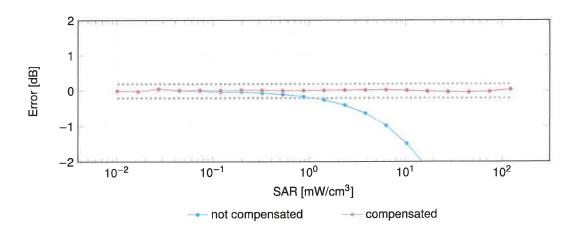


Uncertainty of Axial Isotropy Assessment: ±0.5% (k=2)

# Dynamic Range f(SAR<sub>head</sub>)

 $(\text{TEM cell},\,f_{eval}=1900\,\text{MHz})$ 

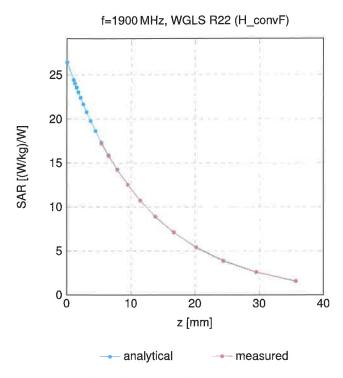




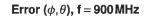
Uncertainty of Linearity Assessment: ±0.6% (k=2)

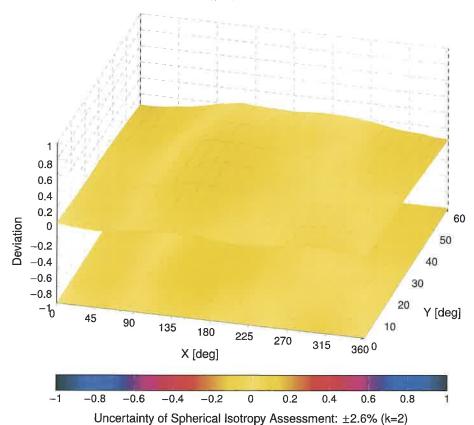
EX3DV4 - SN:7335 January 13, 2025

## **Conversion Factor Assessment**



# **Deviation from Isotropy in Liquid**





### **Calibration Laboratory of**

Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst

C Service suisse d'étalonnage Servizio svizzero di taratura

S Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Client

**Apple**Cupertino, USA

Certificate No.

EUmm-9532 Feb25

## **CALIBRATION CERTIFICATE**

Object

EUmmWV4 - SN:9532

Calibration procedure(s)

QA CAL-02.v9, QA CAL-25.v8, QA CAL-42.v3

Calibration procedure for E-field probes optimized for close near field

evaluations in air

Calibration date

February 17, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22\pm3)$  °C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched. Cal.
Power sensor NRP33T	SN: 100967	28-Mar-24 (No. 217-04038)	Mar-25
Power sensor NRP110T	SN: 101244	04-Apr-24 (No. 0001A300740056)	Apr-25
Spectrum analyzer FSV40	SN: 101832	29-Jan-25 (No. 4030A315009658)	Jan-26
Harmonic mixer FS-Z75	SN: 101566	11-Apr-24 (No. 0001A300740054)	Apr-25
Harmonic mixer FS-Z110	SN: 101633	05-Apr-24 (No. 0001A300740055)	Apr-25
Ref. Probe EUmmWV3	SN: 9374	28-Aug-24 (No. EUmm-9374_Aug24)	Aug-25
DAE4ip	SN: 1662	05-Nov-24 (No. DAE4ip-1662_Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched. Check
Generator APSIN26G	SN: 2023	30-Nov-21 (in house check Jun-24)	In house check: Jun-25
Power sensor NRP40T	SN: 101439	08-Nov-21 (in house check Jun-24)	In house check: Jun-25
Power sensor NRP110T	SN: 101226	15-Nov-21 (in house check Jun-24)	In house check: Jun-25

Name

Function

Signature

Calibrated by

Joanna Lleshaj

Laboratory Technician

Approved by

Sven Kühn

Technical Manager

sued: February 18, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: EUmm-9532\_Feb25

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### Calibration Laboratory of

Schmid & Partner **Engineering AG** 

Zeughausstrasse 43, 8004 Zurich, Switzerland





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Service suisse d'étalonnage Servizio svizzero di taratura

**Swiss Calibration Service** 

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

### Glossary

NORMx,y

sensitivity in free space diode compression point

**DCP** CF

crest factor (1/duty cycle) of the RF signal

A, B, C, D

modulation dependent linearization parameters

Polarization  $\varphi$ 

 $\varphi$  rotation around probe axis

Polarization  $\vartheta$ 

 $\vartheta$  rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e.,  $\vartheta = 0$  is

normal to probe axis

Connector Angle

information used in DASY system to align probe sensor X to the robot coordinate system sensor deviation from the probe axis, used to calculate the field orientation and polarization

Sensor Angles k

is the wave propagation direction

### Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005

### **Methods Applied and Interpretation of Parameters:**

- NORMx,y: Assessed for E-field polarization  $\vartheta = 0$  ( $f \le 900\,\text{MHz}$  in TEM-cell;  $f > 1800\,\text{MHz}$ : R22 waveguide). For frequencies > 6 GHz, the far field in front of waveguide horn antennas is measured for a set of frequencies in various waveguide bands up to 110 GHz.
- DCPx,y: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
  - Note: As the field is measured with a diode detector sensor, it is warrantied that the probe response is linear (E2) below the documented lowest calibrated value.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- The frequency sensor model parameters are determined prior to calibration based on a frequency sweep (sensor model involving resistors R, R<sub>p</sub>, inductance L and capacitors C,  $\dot{C}_{n}$ ).
- Ax,y; Bx,y; Cx,y; Dx,y; VRx,y: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).
- Equivalent Sensor Angle: The two probe sensors are mounted in the same plane at different angles. The angles are assessed using the information gained by determining the NORMx (no uncertainty required).
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide / horn setup.

# Parameters of Probe: EUmmWV4 - SN:9532

#### **Basic Calibration Parameters**

	Sensor X	Sensor Y	Unc (k = 2)
Norm ( $\mu$ V/(V/m) <sup>2</sup> )	0.01753	0.02053	±10.1%
DCP (mV) B	106.0	105.0	±4.7%
Equivalent Sensor Angle	-59.2	35.8	

### Calibration Results for Frequency Response (750 MHz - 110 GHz)

Frequency GHz	Target E-Field V/m	Deviation Sensor X dB	Deviation Sensor Y dB	Unc (k = 2) dB
0.75	77.2	-0.34	-0.29	±0.43
1.8	140.4	-0.02	-0.04	±0.43
2.0	133.0	0.13	0.15	±0.43
2.2	124.8	-0.07	-0.04	±0.43
2.5	123.0	0.09	0.14	±0.43
3.5	256.2	-0.07	-0.06	±0.43
3.7	249.8	0.09	0.08	±0.43
6.6	63.4	-0.10	-0.27	±0.98
8.0	58.5	-0.07	-0.16	±0.98
10.0	57.9	-0.01	0.02	±0.98
15.0	45.6	0.19	0.21	±0.98
26.6	115.1	0.17	0.23	±0.98
30.0	125.1	0.01	0.01	±0.98
35.0	123.5	-0.15	-0.19	±0.98
40.0	101.8	-0.23	-0.32	±0.98
50.0	60.8	0.09	-0.02	±0.98
55.0	73.7	-0.09	-0.05	±0.98
60.0	76.4	0.01	0.03	±0.98
65.0	72.0	0.17	0.13	±0.98
70.0	68.5	0.12	0.07	±0.98
75.0	67.9	-0.04	-0.08	±0.98
75.0	89.9	-0.07	-0.07	±0.98
80.0	88.2	-0.14	-0.10	±0.98
85.0	54.3	-0.03	-0.05	±0.98
90.0	80.6	0.02	0.02	±0.98
92.0	80.8	-0.01	0.03	±0.98
95.0	73.2	-0.05	-0.02	±0.98
97.0	65.9	-0.03	-0.04	±0.98
100.0	63.4	0.03	0.05	±0.98
105.0	63.2	-0.10	-0.12	±0.98
110.0	72.1	0.07	0.05	±0.98

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

 $<sup>^{\</sup>mbox{\footnotesize B}}$  Linearization parameter uncertainty for maximum specified field strength.

# Parameters of Probe: EUmmWV4 - SN:9532

## **Calibration Results for Modulation Response**

UID	Communication System Name		Α	В	С	D	VR	Max	Max
	•		dB	$dB\sqrt{\mu V}$		dB	m۷	dev.	Unc <sup>E</sup>
				• -					k = 2
0	CW	X	0.00	0.00	1.00	0.00	123.9	±2.5%	±4.7%
		Y	0.00	0.00	1.00		69.0		
10352	Pulse Waveform (200Hz, 10%)	X	2.34	60.00	14.87	10.00	6.0	±1.0%	±9.6%
	,	Y	2.06	60.00	15.63		6.0		
10353	Pulse Waveform (200Hz, 20%)	X	1.62	60.00	13.75	6.99	12.0	±1.1%	±9.6%
		Y	1.42	60.00	14.64		12.0		
10354	Pulse Waveform (200Hz, 40%)	Х	0.99	60.27	12.69	3.98	23.0	±1.5%	±9.6%
	·	Y	0.89	60.00	13.44		23.0		
10355	Pulse Waveform (200Hz, 60%)	X	0.58	60.00	12.08	2.22	27.0	±1.1%	±9.6%
		Y	0.63	60.00	12.37		27.0		
10387	QPSK Waveform, 1 MHz	X	1.15	60.00	12.44	1.00	22.0	±1.2%	±9.6%
		Y	1.27	60.00	12.04		22.0		
10388	QPSK Waveform, 10 MHz	X	1.23	60.00	12.30	0.00	22.0	±0.6%	±9.6%
		Y	1.45	60.00	11.85		22.0		
10396	64-QAM Waveform, 100 kHz	X	3.26	66.13	16.37	3.01	17.0	±0.6%	±9.6%
		Y	2.13	60.00	13.90	]	17.0		
10399	64-QAM Waveform, 40 MHz	X	2.02	60.00	12.67	0.00	19.0	±0.8%	±9.6%
		Y	2.20	60.00	12.43	1	19.0		
10414	WLAN CCDF, 64-QAM, 40 MHz	X	3.16	60.17	13.12	0.00	12.0	±1.0%	±9.6%
		Y	3.29	60.00	12.87	1	12.0	1	

Note: For details on UID parameters see Appendix

E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

## Parameters of Probe: EUmmWV4 - SN:9532

### **Calibration Results for Linearity Response**

Frequency GHz	Target E-Field V/m	Deviation Sensor X dB	Deviation Sensor Y dB	Unc ( <i>k</i> = 2) dB
0.9	50.0	-0.02	-0.13	±0.2
0.9	100.0	-0.02	0.01	±0.2
0.9	500.0	-0.01	-0.01	±0.2
0.9	1000.0	0.01	0.01	±0.2
0.9	1500.0	-0.00	0.01	±0.2
0.9	2100.0	-0.02	0.00	±0.2

# Sensor Frequency Model Parameters (750 MHz – 55 GHz)

	Sensor X	Sensor Y
R (Ω)	61.95	93.28
R <sub>p</sub> (Ω)	83.25	116.19
L (nH)	0.05692	0.07457
C (pF)	0.2808	0.2696
C <sub>p</sub> (pF)	0.1065	0.0780

## **Sensor Frequency Model Parameters (55 GHz – 110 GHz)**

	Sensor X	Sensor Y
R (Ω)	18.10	24.81
R <sub>p</sub> (Ω)	102.72	127.19
L (nH)	0.05806	0.07297
C (pF)	0.0719	0.0599
C <sub>p</sub> (pF)	0.0917	0.0704

### **Sensor Model Parameters**

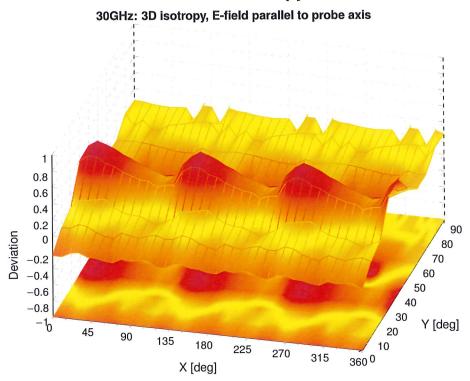
	C1 fF	C2 fF	α V <sup>-1</sup>	T1 msV <sup>-2</sup>	T2 msV <sup>-1</sup>	T3 ms	T4 V <sup>-2</sup>	T5 V <sup>-1</sup>	Т6
Х	50.7	363.96	33.11	0.92	5.71	5.00	0.00	1.45	1.01
У	46.2	331.69	33.08	0.92	5.07	5.03	0.00	1.81	1.01

### **Other Probe Parameters**

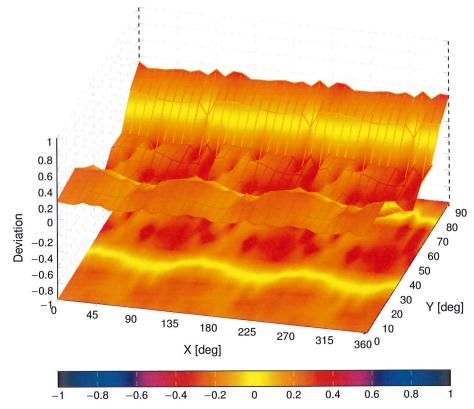
Sensor Arrangement	Rectangular
Connector Angle	-72.3°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	320 mm
Probe Body Diameter	8 mm
Tip Length	23 mm
Tip Diameter	8.0 mm
Probe Tip to Sensor X Calibration Point	1.5 mm
Probe Tip to Sensor Y Calibration Point	1.5 mm

Certificate No: EUmm-9532\_Feb25

### **Deviation from Isotropy in Air**



60GHz: 3D isotropy, E-field parallel to probe axis



Probe isotropy for E<sub>tot</sub>: probe rotated  $\phi=0^\circ$  to 360°, tilted from field propagation direction  $\vec{k}$  Parallel to the field propagation ( $\psi=0^\circ-90^\circ$ ) at 30 GHz: deviation within  $\pm 0.49$  dB Parallel to the field propagation ( $\psi=0^\circ-90^\circ$ ) at 60 GHz: deviation within  $\pm 0.38$  dB